INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)					Docket Number (Optional) 126715-1/GE4	_ ^	Application Number 10/065,881			
					Applicant(s) Christopher Kapusta et al.					
					Filing Date November 27, 20	G	Group Art Unit 2874			
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										

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Patent and Trademark Office \* U.S. DEPARTMENT OF COMMERCE

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				126715-1	10/065.881						
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